Electrical injection of spin-polarized electrons and electrical detection of dynamic nuclear polarization using a Heusler alloy spin source

Takafumi Akiho, Jinhai Shan, Hong-xi Liu, Ken-ichi Matsuda, Masafumi Yamamoto, and Tetsuya Uemura

Division of Electronics for Informatics, Hokkaido University, Sapporo 060-0814, Japan
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We demonstrated electrical spin injection from a half-metallic Heusler alloy Co2MnSi electrode into a GaAs channel through observation of a spin-valve signal and a Hanle signal in the four-terminal nonlocal geometry. Furthermore, we electrically detected a nuclear field acting on electron spins, which was produced by the dynamic nuclear polarization, through observation of transient oblique Hanle signals. Samples with a Co2MnSi spin source exhibited higher spin-injection efficiency and a larger nuclear field compared to samples with a CoFe/FM spin source, suggesting that the spin polarization of Co2MnSi is higher. This higher polarization is promising for realizing future spintronic devices and for understanding spin interactions as well as spin-dependent transport properties in a semiconductor channel.

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I. INTRODUCTION

The injection and detection of spin-polarized electrons using ferromagnet/semiconductor heterojunctions have attracted much interest for creating viable spintronic devices featuring nonvolatile, reconfigurable logic functions and ultralow power consumption. The spin injection from a ferromagnetic electrode of Fe or CoFe into GaAs, Si, or Ge has been observed optically in spin light-emitting diodes (spin-LEDs) and also electrically in lateral spin-transport devices through nonlocal geometry. Lou et al. demonstrated electrical spin injection in Fe/GaAs Schottky tunnel junctions through the observation of spin-valve signals and Hanle signals in a nonlocal configuration. The observation of both signals provides direct evidence of spin injection and transport. Salis et al. investigated the temperature dependence of the spin signal in Fe/GaAs and reported achieving spin injection at room temperature. We also achieved spin injection in Co90Fe50 (CoFe)/n-GaAs Schottky tunnel junctions with an improved temperature dependence.

Along with spin injection and detection, the understanding of spin interactions in semiconductors, such as spin-orbit, hyperfine, or spin-exchange coupling, is an important part of spintronics research. In particular, the interplay between electron spins and nuclear spins due to the hyperfine interaction has been studied extensively for application to quantum information devices based on nuclear spins as well as for understanding the transport properties of electron spins in semiconductors. The hyperfine interaction transfers the angular momentum from polarized electrons to nuclei, leading to an effective polarization of nuclear spins, referred to as dynamic nuclear polarization (DNP). In contrast, polarized nuclear spins affect electron spins as an effective magnetic field or Overhauser field. Thus, one can evaluate the degree of nuclear polarization through the strength of the Overhauser field. To detect the nuclear field, oblique Hanle effect measurements have been widely used, and both optical detection through a spin-LED with an Fe electrode and recently electrical detection through a lateral spin-transport device with an Fe or (Ga,Mn)As electrode have been demonstrated.

Highly spin-polarized ferromagnetic material is indispensable for creating highly spin-polarized states of both electrons and nuclei. Co-based Heusler alloys are one candidate for a highly polarized spin source because of the half-metallic ferromagnetic nature theoretically predicted for many of these alloys and because of their high Curie temperatures, which are well above room temperature. There have been several reports on spin injection through spin-LEDs with Co-based Heusler alloy electrodes. The reported spin-injection efficiency of these devices, however, has been less than that with an Fe electrode. Moreover, there has been no report on the electrical detection of spin injection using a lateral spin-transport device with a Heusler alloy electrode. Thus, the applicability of Co-based Heusler alloys to spin injection has not been fully clarified.

Recently, we found that fully epitaxial Co2MnSi/MgO/Co2MnSi magnetic tunnel junctions (MTJs) with Mn-rich Co2MnSi electrodes exhibit high tunneling magnetoresistance (TMR) ratios of up to 1995% at 4.2 K and up to 354% at 290 K. The observed TMR ratios for MTJs with Mn-rich Co2MnSi electrodes are attributed to suppressed CoMn antisites, which cause a reduced density of minority-spin in-gap states around EF. Furthermore, we reported high TMR ratios of 1135% at 4.2 K and 443% at 290 K in an MTJ having a Co2MnSi upper electrode via an ultrathin CoFe insertion layer on a MgO tunnel barrier in combination with a CoFe lower electrode—i.e., a Co2MnSi upper electrode/CoFe insertion layer/MgO barrier/CoFe lower electrode MTJ (Ref. 30)—indicating a large spin polarization for Co2MnSi. Thus, Co2MnSi/CoFe bilayers are promising for effectively creating and detecting polarized spin states and the Overhauser field in semiconductors.

The purpose of this study is twofold. One purpose is to demonstrate spin injection from the Heusler alloy Co2MnSi into GaAs in a four-terminal nonlocal device with Co2MnSi/CoFe/n-GaAs Schottky tunnel junctions, in which Co2MnSi works as a spin source. The second purpose is to understand the transient behavior of the nuclear spins in GaAs channels. For the second purpose, we have investigated the Overhauser field produced by the DNP through the observation of transient oblique Hanle signals in Co2MnSi/CoFe/n-GaAs...
II. EXPERIMENTAL METHODS

Layer structures consisting of (from the substrate side) a 250-nm-thick undoped GaAs buffer layer, a 2.5-μm-thick n^-GaAs channel layer, a 15-nm-thick n^-GaAs transition layer, and a 15-nm-thick n^-GaAs layer were grown by molecular beam epitaxy at 590 °C on semi-insulating GaAs(001) substrates. The doping concentration of the n^-GaAs channel was chosen to be 3 × 10^{16} cm^{-3}, and the doping concentration of the n^-GaAs was 5 × 10^{18} cm^{-3} to form a narrow Schottky barrier. The samples were then capped with an arsenic protective layer and transported in air to an ultrahigh vacuum chamber capable of magnetron sputtering. After the arsenic cap was removed by heating the samples to 300 °C, a 1.1-nm-thick ultrathin CoFe layer and a 5-nm-thick Co2MnSi layer were deposited by magnetron sputtering at room temperature and successively annealed in situ at 350 °C. The Co2MnSi layer was deposited by cosputtering from a Co2MnSi target and a Mn target. The film composition of the Co2MnSi film was chosen to be Co2MnM1.30Si0.88 to suppress harmful CoMn antisites. The ultrathin CoFe layer was inserted to improve the structural quality of the Co2MnSi layer. Last, a 5-nm-thick Ru cap layer was deposited using magnetron sputtering at room temperature. Using electron beam lithography and Ar ion-milling techniques, lateral spin-transport devices, as shown in Fig. 1, were fabricated. The size of the injector contact (contact-2) and detector contact (contact-3) were 0.5 × 10 μm and 1.0 × 10 μm, respectively, and the spacing (d) between them was 0.5 or 4.0 μm. We defined the longer direction of the junction as the y axis direction. The sample was evaluated in a four-terminal nonlocal geometry in which the nonlocal voltage between contact-3 and contact-4 was measured under a bias voltage (V) of −40 μA supplied between contact-2 and contact-1 at 4.2 K as functions of the in-plane magnetic field for spin-valve effect measurements, the out-of-plane magnetic field for Hanle effect measurements, and the oblique magnetic field for oblique Hanle effect measurements. The bias voltage was defined with respect to the n-GaAs. As a reference, samples with a 5-nm-thick CoFe single layer were identically fabricated with the same conditions.

III. RESULTS AND DISCUSSION

A. Spin-valve effect and Hanle effect

From the measurements of the tunneling anisotropic magnetoresistance effect (TAMR) for both injector and detector contacts (not shown), we found that the easy axis of the magnetization of the Co2MnSi/CoFe bilayer was along the shorter direction of the junction (the x axis direction or [110]GaAs). Thus, the strong uniaxial-type anisotropy anisotropy along the x axis direction and relatively weak shape anisotropy along the y axis direction were induced in the Co2MnSi/CoFe bilayer. There have been several reports that ferromagnetic thin films, including Co-based Heusler alloys, epitaxially grown on GaAs(001) substrates have an uniaxial-type anisotropy with an easy axis of either the [110]GaAs or [1–10]GaAs direction and whose strength and direction depend on the surface reconstruction superstructures of GaAs and/or ferromagnet materials. In this study, the fabricated Co2MnSi/CoFe/n-GaAs junction had an easy axis of the [110]GaAs direction, which corresponded to the x axis direction. On the other hand, the CoFe/n-GaAs junction of the reference sample had an easy axis of the [1–10]GaAs direction, which corresponded to the y axis direction.

Figure 2 shows a plot of nonlocal voltage as a function of the in-plane magnetic field (B_x) for a lateral spin-transport device with Co2MnSi/CoFe/n-GaAs Schottky tunnel junctions. The magnetic field was applied along the x axis direction, which corresponded to the easy axis for the magnetization of the Co2MnSi/CoFe bilayer. A bias current (I) of −40 μA was supplied, where electron spins were injected from the Co2MnSi to n-GaAs. We subtracted a background signal consisting of a constant term and linear and quadratic terms of B_x so that the nonlocal voltage at B_x = 0 was set to 0 V because electron spins are completely depolarized at B_x = 0. The nonlocal voltage at B_x = 0 was set to 0 V because electron spins are completely depolarized at B_x = 0 due to precession by the Overhauser field, as will be explained in Sec. III C. Although a similar background signal was observed in identical experiments, its origin is still not well understood. A clear spin-valve-like change of the nonlocal voltage was observed at B_x ≅ +25 and −30 mT due to switching between the parallel (P) and antiparallel (AP) states.
gradually decreased (increased) as $|B_z|$ increased, and the two curves merged at a large $B_z$. These results clearly indicate the Hanle effect. In the Hanle effect, the nonlocal voltage as a function of $B_z$ can be expressed by

$$V_{NL}(B_z) = \pm P_{\text{inj}} \cdot P_{\text{det}} \left( \frac{\rho_{\text{SF}}}{S} \right) \left( \frac{I_{\text{SF}}}{\tau_{\text{SF}}} \right) I \int_0^\infty \frac{1}{\sqrt{4\pi D t}} \exp \left( -\frac{d^2}{4Dt} \right) \cos(\omega_L t) \exp \left( -\frac{t}{\tau_{\text{SF}}} \right) dt, \quad (1)$$

where $P_{\text{inj(det)}}$ is the spin polarization of the injector (detector) contact, $\rho$ is the resistivity of the GaAs channel, $S$ is the area of the channel cross section, $I_{\text{SF}}$ is the spin-diffusion length, $d$ is the distance between contact-2 and contact-3, $\tau_{\text{SF}}$ is the spin lifetime, $I$ is the injected current, $D = L_{\text{SF}}^2/\tau_{\text{SF}}$ is the diffusion constant, $\omega_L = g \mu_B B / h$ is the Larmor frequency, $g (= -0.44)$ is an electron $g$ factor for GaAs, $\mu_B$ is the Bohr magneton, and $h$ is the reduced Planck’s constant. The + (−) sign on the right-hand side of Eq. (1) corresponds to the P (AP) configuration. The observed Hanle curves can be fitted well with Eq. (1). The estimated spin lifetime $\tau_{\text{SF}}$ was 50 ns. This value of the spin lifetime is comparable to those obtained for GaAs with a doping concentration of $10^{16}$ cm$^{-3}$ (Ref. 41), suggesting that spins were injected into the GaAs channel. The estimated spin diffusion length $L_{\text{SF}}$ was 5 μm. The Hanle signal for the P state was approximately 10 μV, and that for the AP state was approximately 8 μV, so the total of both signals was approximately 18 μV. This value agrees with the result of the spin-valve effect. The smaller amplitude of the Hanle curve for the AP state was due to the imperfect formation of the AP state, as previously described. The observation of the spin-valve signal and Hanle signal in the four-terminal nonlocal geometry provides direct evidence of the spin injection, detection, and transport in GaAs.

**B. Comparison of spin polarization between Co$_2$MnSi and CoFe**

In this section, we compare the magnitude of the spin signal ($V_{P}$) and spin polarization between the sample with a Co$_2$MnSi electrode and that with a CoFe electrode. Figure 4 shows the bias current dependence of $V_{P}$ for both a Co$_2$MnSi/CoFe/n-GaAs sample and a CoFe/n-GaAs sample. The negative (positive) bias region corresponds to the spin injection (extraction), where spin-polarized electrons tunnel from ferromagnet (semiconductor) to semiconductor (ferromagnet). Here, the spacing ($d$) between the injector and detector contacts was 4.0 μm for both samples. The bias current dependence of $V_{P}$ clearly differed between the Co$_2$MnSi/CoFe/n-GaAs sample and the CoFe/n-GaAs sample. For the Co$_2$MnSi/CoFe/n-GaAs sample, $V_{P}$ increased monotonically as $I/I$ increased in the negative-bias region, while no clear spin signal was observed in the positive-bias region. On the other hand, for the CoFe/n-GaAs sample, $V_{P}$ increased with increasing $I/I$, reached a peak value at $I = -25$ μA, and then decreased with increasing $I/I$ in the negative-bias region, while it increased monotonically with increasing $I/I$ in the positive-bias region.

By integrating Eq. (1) under $B_z = 0$, $V_{P}$ is given by

$$V_P = \frac{1}{2} P_{\text{inj}} \cdot P_{\text{det}} \left( \frac{\rho_{\text{SF}}}{S} \right) \exp \left( -\frac{d}{L_{\text{SF}}} \right) I. \quad (2)$$

**FIG. 2.** (Color online) Plot of nonlocal voltage as a function of in-plane magnetic field ($B_x$) for a lateral spin-transport device with Co$_2$MnSi/CoFe/n-GaAs junctions. A background signal consisting of a constant term and linear and quadratic terms of $B_x$ has been subtracted.

**FIG. 3.** (Color online) Plot of nonlocal voltage as a function of out-of-plane magnetic field ($B_z$) for a Co$_2$MnSi/CoFe/n-GaAs sample for both P (upper curve) and AP (lower curve) configurations. The solid lines are the result of the fitting using Eq. (1).
For a Co$_2$MnSi junction resistance also affects the spin-injection efficiency,46 heterointerface are affected by the bias condition. Although the and sign of the spin polarization for a ferromagnet/GaAs\textbf{\textsuperscript{17}} condition is satisfied in our devices, as shown later. Thus, the junction resistance was normalized by the spin resistance of the GaAs channel.

The above equation is valid when the junction resistance is much larger than the spin resistance of the channel, which condition is satisfied in our devices, as shown later. Thus, $|V_{pl}|$ depends on $I$, $P_{inj}$, $\rho_s$, $S$, $l_{S,F}$, and $d$. Since the channel structure of GaAs is the same for both samples, the values of $\rho_s$, $S$, $l_{S,F}$, and $d$ are the same. Therefore, the difference in $|V_{pl}|$ vs $I$ characteristics between the two samples comes from the difference in the $P_{inj}$ $P_{det}$ products. This result indicates that the spin polarization at the 1.1-nm-thick CoFe/GaAs interface of Co$_2$MnSi/CoFe/1.1 nm)/GaAs heterojunction differs from that at the 5-nm-thick CoFe/GaAs interface, which means that Co$_2$MnSi works as a spin source in the Co$_2$MnSi/CoFe/n-GaAs sample even though 1.1-nm-thick CoFe was inserted between the Co$_2$MnSi and GaAs. This is reasonable because the thickness of the inserted CoFe (1.1-nm) layer was less than the spin diffusion length of CoFe ($\sim$10 nm).42

The nonlinear relations between $|V_{pl}|$ and $I$ shown in Fig. 4 indicate that the value of $|P_{inj}|$ $P_{det}^{1/2}$ is not constant against the bias voltage. There have been several experimental\textsuperscript{6,7,12} and theoretical\textsuperscript{43-48} investigations into whether the magnitude and sign of the spin polarization for a ferromagnet/GaAs heterointerface are affected by the bias condition. Although the junction resistance also affects the spin-injection efficiency, the effect was negligible in our devices. The inset in Fig. 4 shows the junction resistance of the injector contacts of both CoFe and Co$_2$MnSi/CoFe as a function of the bias current. The junction resistance was normalized by the spin resistance of the GaAs channel, $\rho_{S,F}/S$. As shown in the inset, the junction resistance is at least two orders of magnitude larger than the spin resistance for almost all bias regions investigated in this study. Thus, $V_P$ does not depend on the junction resistance, as indicated by Eq. (2), and the nonlinear relations between $|V_{pl}|$ and $I$ result from the change in the $P_{inj}$ $P_{det}$ value by the bias voltage rather than from the change in the junction resistance. Table I summarizes the values of $|P_{inj}|$ $P_{det}^{1/2}$ in a low negative-bias current region, in which the values of $|P_{inj}|$ $P_{det}^{1/2}$ are almost constant. The value for a sample without postdeposition annealing\textsuperscript{12} is also shown for comparison. Importantly, the value of $|P_{inj}|$ $P_{det}^{1/2}$ for the Co$_2$MnSi/CoFe/n-GaAs sample is larger than those for the CoFe/n-GaAs samples. The larger value of $|P_{inj}|$ $P_{det}^{1/2}$ obtained for the Co$_2$MnSi/CoFe/n-GaAs sample cannot be explained by the difference of the junction resistance, because the junction resistances of both the samples were much larger than the spin resistance, resulting in the value of $|P_{inj}|$ $P_{det}^{1/2}$ being independent of the junction resistance. These results indicate that Co$_2$MnSi has higher spin polarization and that a Heusler alloy is a promising spin source for efficient spin injection into a semiconductor. Considering that the TMR ratios in MTJs with Co$_2$MnSi electrodes increase with increasing annealing temperature around 550 °C,\textsuperscript{47} there is much room to improve the spin-injection efficiency with our sample. It should be noted, however, that high-temperature annealing may lead to interdiffusion of atomic species at a ferromagnet/GaAs interface, resulting in the degradation of spin-injection properties. Thus, the annealing temperature of the Co$_2$MnSi layer must be optimized to simultaneously obtain high spin polarization and prevent interdiffusion.

### C. Oblique Hanle effect

In this section, we describe the electrical detection of the Overhauser field through the observation of oblique Hanle signals. The steady-state Overhauser field ($B_{ob}$) induced by the DNP can be expressed by\textsuperscript{48}

$$B_{ob} = f \frac{B_{ob}}{S} \frac{S}{S + \xi} B_{ob},$$  \hspace{1cm} (3)

where $f$ ($\leq 1$) is the leakage factor and $b_s$ is the effective field due to the polarization of nuclear spins, which takes the negative value of $-17$ T in GaAs for the theoretical ideal case.\textsuperscript{49} $S$ is the average electron spin ($S = 1/2$ corresponds to $P_{GaAs} = 100\%$). $B_{ob}$ is the external magnetic field, $B_{f}$ is the local dipolar field experienced by the nuclei, and $\xi$ is a numerical coefficient on the order of unity, which depends on the nature of the spin-spin interactions.\textsuperscript{48,49} In the oblique Hanle effect measurement, $B_{ob}$ is applied obliquely with respect to $S$ so that electron spins make precession with $B_{ob}$ and $B_{ob}$. Note that in the conventional Hanle effect measurement, in which $S$ and $B_{ob}$ are orthogonal, no nuclear field is generated because $B_{ob} S = 0$. Figure 5(a) shows a simulated nonlocal voltage using Eqs. (1) and (3) as a function of $B_{ob}$. Here, we set $S = S_x$ and $B_{ob} = B_{ob}(\sin \theta + \cos \phi)$, where $x$ and $z$ are unit vectors along the $x$ axis and $z$ axis directions, respectively. Considering that electron spins experience the total magnetic

![Image](https://via.placeholder.com/200)

**Figure 4.** (Color online) Bias current dependence of $V_{pl}$ measured for a Co$_2$MnSi/CoFe/n-GaAs sample and a CoFe/n-GaAs reference sample. The solid lines indicate linear least-squares fitting in the low negative-bias region. Inset shows the bias current dependence of the injector junction resistance for both Co$_2$MnSi/CoFe/n-GaAs and CoFe/n-GaAs. The junction resistance was normalized by the spin resistance of the GaAs channel.

| Sample structure | Annealing temperature (°C) | $|P_{inj}|$ $P_{det}^{1/2}$ (%) |
|------------------|-----------------------------|-----------------------------|
| Co$_2$MnSi/CoFe/n-GaAs | 350 | 4.4 |
| CoFe/n-GaAs | 350 | 3.5 |
| CoFe/n-GaAs\textsuperscript{12} | — | 3.0 |
field of $\mathbf{B}_{\text{ob}} + \mathbf{B}_n$ and $\mathbf{B}_n$ is negative, the behavior of the nonlocal voltage shown in Fig. 5(a) can be explained as follows. At $B_{\text{ob}} > 0$, $\mathbf{B}_n$ and $\mathbf{B}_{\text{ob}}$ are antiparallel, and electron spins experience a smaller effective magnetic field than $|\mathbf{B}_{\text{ob}}|$. When $\mathbf{B}_n$ and $\mathbf{B}_{\text{ob}}$ cancel each other, electron spins get depolarized and the nonlocal voltage shows a satellite peak. At $B_{\text{ob}} < 0$, on the other hand, no satellite peak appears, because $\mathbf{B}_n$ and $\mathbf{B}_{\text{ob}}$ are parallel, and no cancelation occurs. Since it takes several seconds or more for the nuclear field to reach the steady state,19,20 very slow sweeping of the external magnetic field is necessary for the steady-state measurement.

Figure 5(b) shows the $B_{\text{ob}}$ dependence of the nonlocal voltage for a Co$_2$MnSi/CoFe/n-GaAs sample in the parallel magnetization configuration. Since $S$ is parallel to the $x$ axis direction in the Co$_2$MnSi/CoFe/n-GaAs sample, we applied $\mathbf{B}_{\text{ob}}$ along the direction oblique by 15° from the $z$ axis in the $x$-$z$ plane so that electron spins were affected by $\mathbf{B}_{\text{ob}}$ and $\mathbf{B}_n$. The device was first initialized at $B_{\text{ob}} = +42$ mT for a hold time ($t_{\text{hold}}$) of 60 s at an injection current of $-40 \mu A$ so that nuclear spins became dynamically polarized. The magnetic field was then swept from $+42$ to $-42$ mT (negative sweep direction) and was swept back from $-42$ to $+42$ mT (positive sweep direction), with a sweep rate of $0.18$ mT/s. This sweep rate was too fast for the nuclear field to reach the steady state. Compared to the steady-state signal, the observed transient oblique Hanle signal has two features: (1) an additional satellite peak is observed at $-10$ mT in the negative sweep direction, and (2) no satellite peak is observed in the positive sweep direction, showing a clear hysteretic nature depending on the sweep direction.

To explain the observed oblique Hanle signal, we discuss the behavior of the nuclear spin in the transient state. In the negative sweep direction, the behavior of the nuclear field for $B_{\text{ob}} > 0$ is qualitatively similar to that for the steady-state nuclear field; i.e., the nuclear field is generated along the AP direction to $\mathbf{B}_{\text{ob}}$ during an initial holding time at $B_{\text{ob}} = +42$ mT, and then $\mathbf{B}_{\text{ob}}$ and $\mathbf{B}_n$ cancel each other at $B_{\text{ob}} = +33$ mT. In a similar way, the observation of the satellite peak at $B_{\text{ob}} = -10$ mT indicates that electron spins are repolarized due to the cancellation of $\mathbf{B}_{\text{ob}}$ and $\mathbf{B}_n$. However, this AP state for $\mathbf{B}_n$ with respect to $\mathbf{B}_{\text{ob}}$ is the transient state because $\mathbf{B}_n$ and $\mathbf{B}_{\text{ob}}$ are in a P configuration at $B_{\text{ob}} < 0$ in the steady state, as indicated by Eq. (3). Then, $\mathbf{B}_n$ gradually goes to the steady state, and it reaches almost the steady state at $B_{\text{ob}} = -42$ mT, resulting in being parallel to $\mathbf{B}_{\text{ob}}$. In the positive sweep direction, $\mathbf{B}_{\text{ob}}$ and $\mathbf{B}_n$ are parallel at $B_{\text{ob}} < 0$, and this P configuration is transiently kept just after $\mathbf{B}_{\text{ob}}$ is reversed from the negative direction to the positive one. Thus, no cancellation occurs between $\mathbf{B}_{\text{ob}}$ and $\mathbf{B}_n$, resulting in the disappearance of the satellite peak at $B_{\text{ob}} > 0$ for the positive sweep direction.

As discussed above, the transient oblique Hanle signals observed in the Co$_2$MnSi/CoFe/n-GaAs sample can be qualitatively explained by adiabatic nuclear spin reversal; that is, the nuclear spins adiabatically rotate by 180° when the magnetic field crosses zero.19,21 A similar adiabatic nuclear spin reversal has been reported in the electrical detection of spin-valve signals for lateral spin-transport devices with Fe/GaAs Schottky tunnel junctions21 and in the optical detection of oblique Hanle signals for a spin-LED with a MnSb ferromagnet electrode.19 However, there has been no report on the transient behavior of the nuclear spins through the electrical detection of oblique Hanle signals. In this study, we have shown that adiabatic nuclear spin reversal with the magnetic field is an important factor in understanding transient oblique Hanle signals.

In the spin-valve signal measurement for the Co$_2$MnSi/CoFe/n-GaAs sample, the dip structure was observed at $B_x = 0$, as shown in Fig. 2, indicating that electron spins were depolarized. This contrasted with the result for CoFe/n-GaAs samples, in which the dip structure was not clearly observed and the spin-valve signal was almost unchanged from $V_F$ at a zero in-plane magnetic field.12 For the Co$_2$MnSi/CoFe/n-GaAs sample, the Overhauser field with its direction parallel or antiparallel to $\mathbf{B}_n$ was generated at a sufficiently large $|\mathbf{B}_n|$. Since the magnetization of the Co$_2$MnSi/CoFe electrode oriented to the $x$ axis direction, the stray field from the Co$_2$MnSi/CoFe electrode penetrated almost vertically into the GaAs channel. Thus, the Overhauser...
field dynamically rotated and oriented to the direction of the stray field at $B_s = 0$, causing electron spins to be completely depolarized. Note that since the stray field is comparable to or smaller than $B_s$, the strength of the steady-state Overhauser field generated by the stray field as well as that of the stray field itself is too small for electron spins to be completely depolarized. On the other hand, for the CoFe/n-GaAs sample, the stray field penetrated along the $y$ axis direction, since the magnetization of the CoFe/n-GaAs electrode oriented to the $y$ axis direction. Thus, the direction of the Overhauser field oriented parallel or antiparallel to the $y$ axis direction, resulting in no electron spin precession occurring.

One can estimate the strength of the nuclear field from the oblique Hanle signal because $B_{\text{ob}} + B_s = 0$ is satisfied at the satellite peak position. Furthermore, one can estimate through transient analysis the time scale needed for the nuclear spins to reach a steady state. Figure 6 shows the $t_{\text{hold}}$ dependence of the observed satellite peak position for $B_{\text{ob}} > 0$. The circles and triangles indicate the data for the Co$_2$MnSi/CoFe/n-GaAs sample and those for the nonannealed CoFe/n-GaAs sample, respectively. For both samples, the satellite peak position shows almost exponential dependence. From the rate equation for the DNP, the time evolution of the nuclear field is given by

$$B_N(t) = B_N(\infty) \left\{1 - \exp \left[ -t \left( \frac{1}{T_P} + \frac{1}{T_I} \right) \right]\right\},$$

where $B_N(\infty)$ is the steady-state Overhauser field, which is given by Eq. (3) and $T_P^{-1}$ and $T_I^{-1}$ are the rates for nuclear polarization through DNP and that for nuclear spin relaxation through nuclear-lattice interaction, respectively. Importantly, the saturation value of the satellite peak position of 37 mT for the Co$_2$MnSi/CoFe/n-GaAs sample is larger than that of 16 mT for the CoFe/n-GaAs sample, suggesting a greater Overhauser magnetic field due to the higher spin polarization of Co$_2$MnSi. The characteristic time, $(1/T_P + 1/T_I)^{-1}$, estimated from the exponential dependence of the satellite peak positions on $t_{\text{hold}}$ is approximately 77 s for the Co$_2$MnSi/CoFe/n-GaAs sample and 213 s for the CoFe/n-GaAs sample, respectively. These values are reasonable for the time scale needed for the nuclear spins to reach the steady state through the DNP.$^{18,19,21}$ The value of $I_{2Si}$ which corresponds to the spin polarization in the channel, estimated from the saturation value of the Overhauser field, was 5.4% for the Co$_2$MnSi/CoFe/n-GaAs sample and 2.3% for the CoFe/n-GaAs sample, respectively. These values are comparable to the effective spin polarizations of $|P_{\text{inj}}|P_{\text{det}}|^{1/2}$, estimated from the $|V_{\text{d}}|$ for both samples (see Table I).

IV. CONCLUSION

We achieved efficient spin injection and a resultant efficient DNP by using a Co$_2$MnSi spin source. The maximum spin polarization of both electron spins and nuclear spins in the GaAs channel observed in the sample with Co$_2$MnSi electrodes was larger than that observed in the reference sample with CoFe electrodes; this was due to higher spin polarization of Co$_2$MnSi. These results indicate that the Heusler alloy is a promising spin source for spin injection into a semiconductor.

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